Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/694,117	CHEN ET AL.
Examiner	Art Unit

William Boddie

2629

SEARCHED				
Subclass	Date	Examiner		
98-100	5/8/2006	WLB		
64-100	5/8/2006	WLB		
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	98-100 64-100	Subclass Date 98-100		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
East Search See attached Search History	5/8/2006	WLB
Consulted with A. Awad	5/8/2006	WLB